

FORM PTO 449

Atty. Docket No.

Appln. No.

XA-9730A

**LIST OF DOCUMENTS CITED BY APPLICANT**

Applicant

Mikako UJIIE et al.

Filing Date

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**U.S. PATENT DOCUMENTS**

Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
MS	AA	6,200,121	3/13/01	Tsuruta	425	127	
	AB	2002/0149102	10/02	Hashemi et al.	257	706	
	AC	6,448,507	9/02	Fontecha et al.	174	260	
	AD	5,336,931	8/94	Juskey et al.	257	787	
	AE	2001/0026959	10/01	Jimarez et al.	438	126	
	AF	2002/0084518	7/02	Hasebe et al.	257	676	
	AG	2002/0168798	11/02	Glenn et al.	438	110	
	AH	2003/0042621	3/03	Chen et al.	257	784	
MS	AI	2002/0125557	9/02	Chen et al.	257	686	

**FOREIGN PATENT DOCUMENTS**

Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
MS	AJ	8-181166	7/12/96	JAPAN			abstract
	AK	7-45641	2/14/95	JAPAN			abstract
	AL	8-167678	6/25/96	JAPAN			abstract
	AM	2000-286271	10/13/00	JAPAN			abstract
MS	AN	2000-12578	1/14/00	JAPAN			abstract
	AO						

**OTHER** (including author, title, date, pertinent pages, etc.)

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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.